

## Description

The F0453C is an integrated dual-path RF front-end consisting of an RF switch and two gain stages with 6dB gain control used in the analog front-end receiver of an Active Antenna System (AAS). The F0453C supports frequencies from 3300MHz to 4000MHz.

The F0453C provides 35dB gain with +23dBm OIP3, +15dBm output P1dB, and 1.35dB noise figure at 3500MHz. Gain is reduced 6dB in a single step with a maximum gain settling time of 31ns. The device uses a single 3.3V supply and 130mA of  $I_{DD}$ .

The F0453C is offered in a  $6 \times 6 \times 0.75$  mm, 32-LGA package with  $50\Omega$  input and output amplifier impedances for ease of integration into the signal path.

## Competitive Advantage

- High integration
- Low noise and high linearity
- On-chip matching and bias
- Extremely low current consumption

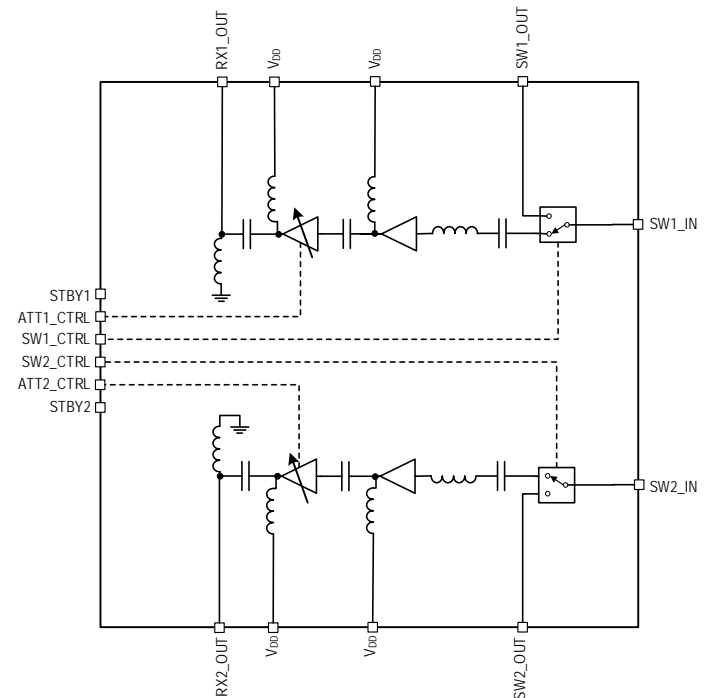
## Typical Applications

- Multi-mode, Multi-carrier receivers
- AAS Rx Front-End
- 4.5G (LTE Advanced)
- 5G NR band n48, n77, and n78

## Features

- Gain at 3500MHz
  - 35dB typical in High Gain Mode
  - 29dB typical in Low Gain Mode
- 1.35dB NF at 3500MHz
- +23dBm OIP3 at 3500MHz
- OP1dB at 3500MHz
  - +15dBm in High Gain Mode
  - +14dBm in Low Gain Mode
- $50\Omega$  single-ended input / output amplifier impedances
- $I_{DD} = 130\text{mA}$
- Independent Standby Mode for power savings
- Supply voltage: +3.15V to +3.45V
- $6 \times 6$  mm, 32-pin LGA package
- $-40^{\circ}\text{C}$  to  $+105^{\circ}\text{C}$  exposed pad operating temperature range

## Block Diagram



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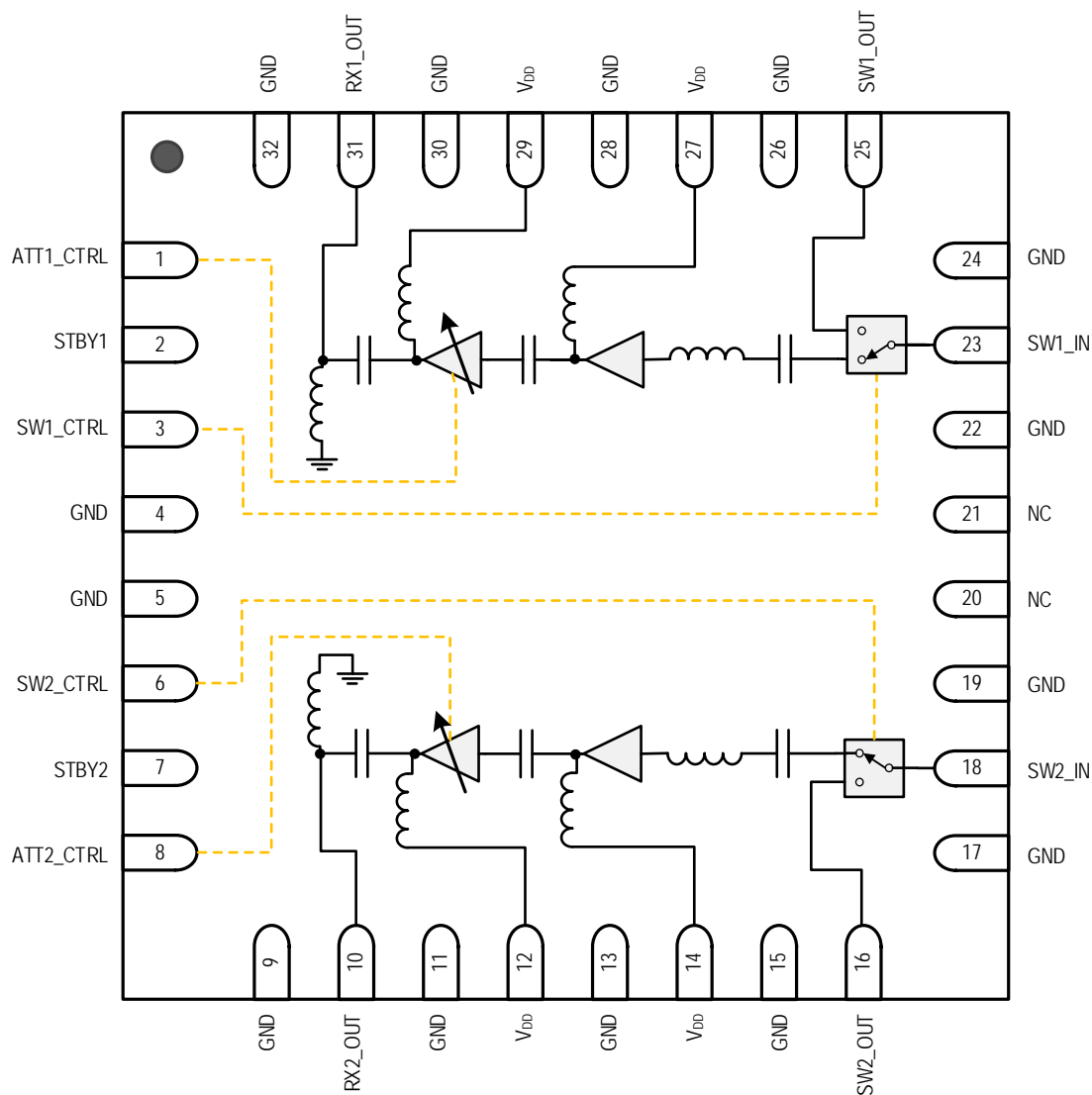
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# Pin Assignments

Figure 1. Pin Assignments for 6 × 6 × 0.75 mm 32-pin LGA – Top View



## Pin Descriptions

Table 1. Pin Descriptions

Number	Name	Description
1	ATT1_CTRL	1-bit 6dB gain control for path 1. (Low/open = no attenuation; High = 6dB attenuation). A 500kΩ pull-down resistor is connected between this input and GND.
2	STBY1	Standby (Low/open = path 1 power ON; High = path 1 power OFF). A 500kΩ pull-down resistor is connected between this input and GND.
3	SW1_CTRL	RF SWITCH 1 control (Low/open = select main RX PATH 1; High = termination). SW1_CTRL also puts path 1 into Standby Mode for minimum current consumption. A 500kΩ pull-down resistor is connected between this input and GND.
4, 5, 9, 11, 13, 15, 17, 19, 22, 24, 26, 28, 30, 32	GND	Ground these pins.
12, 14, 27, 29	VDD	Power supply. Bypass to GND with capacitors shown in the F0453C Application Circuit as close as possible to pin.
6	SW2_CTRL	RF SWITCH 2 control (Low/open = select main RX PATH 2; High = termination). SW2_CTRL also puts path 2 into Standby Mode for minimum current consumption. A 500kΩ pull-down resistor is connected between this input and GND.
7	STBY2	Standby (Low/open = path 2 power ON; High = path 2 power OFF). A 500kΩ pull-down resistor is connected between this input and GND.
8	ATT2_CTRL	1-bit 6dB gain control for path 2. (Low/open = no attenuation; High = 6dB attenuation). A 500kΩ pull-down resistor connects between this input and GND.
10	RX2_OUT	RF output path 2 matched to 50Ω. Use external DC block as close to the pin as possible.
16	SW2_OUT	RF2 switch output matched to 50Ω. Use external 50Ω terminating resistor with proper power rating as required for the application.
18	SW2_IN	RF2 switch input matched to 50Ω. Use external DC block as close to the pin as possible.
23	SW1_IN	RF1 switch input matched to 50Ω. Use external DC block as close to the pin as possible.
25	SW1_OUT	RF1 switch output matched to 50Ω. Use external 50Ω terminating resistor with proper power rating as required for the application.
31	RX1_OUT	RF output path 1 matched to 50Ω. Use external DC block as close to the pin as possible.
20, 21	NC	These pins can be left unconnected, or be connected to ground (recommended). Use a via as close to the pin as possible if grounded.
	— EPAD	Exposed Pad. Internally connected to GND. Solder this exposed pad to a PCB pad that uses multiple ground vias to provide heat transfer out of the device into the PCB ground planes. These multiple via grounds are also required to achieve the noted RF performance.

## Absolute Maximum Ratings

Stresses beyond those listed below may cause permanent damage to the device. Functional operation of the device at these or any other conditions beyond those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 2. Absolute Maximum Ratings

Parameter	Symbol	Minimum	Maximum	Units
V <sub>DD</sub> to GND	V <sub>DD</sub>	-0.3	+3.6	V
STBY1, STBY2, ATT1_CTRL, ATT2_CTRL, SW1_CTRL, SW2_CTRL to GND	V <sub>CTRL</sub>	-0.3	V <sub>DD</sub> + 0.25	V
SW1_IN, SW2_IN, RX1_OUT, RX2_OUT, SW1_OUT, SW2_OUT to GND Externally Applied DC Voltage	V <sub>SW</sub>	-50	50	mV
Tx Mode CW Average Input Power +7.5dB PAR at SW1_IN, SW2_IN ports, 10s, 89% Duty Cycle 50Ω, T <sub>EPAD</sub> = 105°C [a], V <sub>DD</sub> = +3.3V	P <sub>ABS_TX</sub>	+31	+33 [b]	dBm
Rx Mode Average Input Power +7.5dB PAR at SW1_IN, SW2_IN ports, 1 hour single event, 50% Duty Cycle 50Ω, T <sub>EPAD</sub> = 105°C [a], V <sub>DD</sub> = +3.3V	P <sub>ABS_RX</sub>		+8	dBm
Storage Temperature Range	T <sub>ST</sub>	-65	+150	°C
Lead Temperature (soldering, 10s)	T <sub>LEAD</sub>		+260	°C
Electrostatic Discharge – HBM (JEDEC/ESDA JS-001-2012)	V <sub>ESDHBM</sub>		1500 (Class 1C)	V
Electrostatic Discharge – CDM (JEDEC JS-002-2014) ALL pins except pins 16, 18, 23, 25	V <sub>ESDCDM</sub>		500 (Class C2a)	V
Electrostatic Discharge – CDM (JEDEC JS-002-2014) Pins 16, 18, 23, 25	V <sub>ESDCDM</sub>		125 (Class C0b)	V

[a] T<sub>EPAD</sub> = Temperature of the exposed paddle.

[b] RF input exposures greater than +31dBm and up to +33dBm for multiple extended periods will affect device reliability and lifetime if the maximum recommended input junction temperature is exceeded.

## Recommended Operating Conditions

Table 3. Recommended Operating Conditions

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Power Supply Voltage	$V_{DD}$		3.15	3.3	3.45	V
Operating Temperature Range	$T_{EPAD}$	Exposed Paddle	-40		+105	°C
RF Frequency Range	$f_{RF}$		3300		4000	MHz
Tx Mode CW Average Input Power, +7.5dB PAR, Full Life Time <sup>[a]</sup> 50Ω, $V_{DD} = +3.3V$	$P_{MAX\_TX}$	89% Duty Cycle			+30 <sup>[b]</sup>	dBm
Rx Mode CW Average Input Power, +7.5dB PAR, Full Life Time <sup>[a]</sup> 50Ω, $V_{DD} = +3.3V$	$P_{MAX\_RX}$	89% Duty Cycle			-25	dBm
Port Impedance (SW1_IN, SW2_IN, RX1_OUT, RX2_OUT)	$Z_{RF}$			50		Ω
Junction Temperature	$T_J$				+125	°C

[a] Assumes device environmental temperature cycling within the specified exposed pad operating temperature range of -40°C and 105°C and a maximum junction temperature of 125°C.

[b] Operation beyond the maximum recommended operating input power level should be limited and have reduced exposed pad temperatures to maintain device reliability per foundry guidelines. Electrical characteristics and lifetime are not guaranteed for RF input power levels beyond what is specified in this table.

## Electrical Characteristics: General

Table 4. Electrical Characteristics: General

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power =  $-10dBm$ ,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Logic Input High Threshold	$V_{IH}$		1.17 <sup>[a]</sup>		Lower of $(V_{DD}, 3.3)$	V
Logic Input Low Threshold	$V_{IL}$		-0.3		0.55	V
Logic Current	$I_{IH}, I_{IL}$	For each control pin	-10		10	$\mu A$
DC Current	$I_{DD}$	2 paths in Rx Mode		130	180	mA
		1 path in Rx Mode 1 path in Tx Mode		70	100	
		1 path in Rx Mode 1 path in Standby Mode		67		
		1 path in Tx Mode 1 path in Standby Mode		5		
		2 paths in Standby Mode		5		
Gain Step	$G_{STEP}$			6		dB
Gain Step Absolute Error	$G_{STEP\_ERR}$	Relative to maximum gain, over-voltage, and temperature		$\pm 0.5$		dB
Relative Phase Gain Step	$G_{STEP\_PH}$			27		deg
Gain Step Settling Time <sup>[b]</sup>	$G_{STEP\_SET}$	50% control logic to RF output within $\pm 0.1dB$ of final value		21	31	ns
Gain Step Phase Settling Time <sup>[b]</sup>	$G_{STEP\_PHSET}$	50% control logic to RF output within $\pm 1$ degree of final value		19	30	ns
Power ON Switching Time <sup>[b]</sup>	$SW_{ON}$	To Rx Mode from Tx Mode 50% control logic to RF output settled to within $\pm 0.1dB$ of final value			1	$\mu s$
Power OFF Switching Time <sup>[b]</sup>	$SW_{OFF}$	To Tx Mode from Rx Mode 50% control logic to RF input settled within $\pm 0.1dB$ of final value			0.5	$\mu s$



Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Power ON from Standby Mode <sup>[b]</sup>	$SW_{ON\_STANDBY}$	To Rx Mode from Standby Mode 50% STBY to RF output settled within $\pm 0.1$ dB of final value			1	$\mu$ s
Power OFF to Standby Mode <sup>[b]</sup>	$SW_{OFF\_STANDBY}$	To Standby Mode from Rx Mode 50% STBY to gain below -25dB from max gain			1	$\mu$ s

[a] Items in the Minimum/Maximum columns in ***bold italics*** are confirmed by test. Items in the Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b]  $f_{RF} = 3500$ MHz. Assumes the control signal is clean and no external RC circuitry is required on the pin. Adding RC circuitry increases switching time.

## Electrical Characteristics: 3300MHz [1]

Table 5. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3300MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Input Return Loss	RL <sub>IN</sub>	Measured at SW1_IN, SW2_IN High Gain Mode	8 <b>[a]</b>			dB
		Measured at SW1_IN, SW2_IN Low Gain Mode	6			
		Measured at SW1_IN, SW2_IN TX mode <b>[b]</b> <b>[c]</b>	11			
Output Return Loss	RL <sub>OUT</sub>	Measured at RX1_OUT, RX2_OUT, High/Low Gain Modes	5			dB
Reverse Isolation	ISO <sub>REV</sub>	RX1_OUT to SW1_IN, or RX2_OUT to SW2_IN	55	65		dB
Gain	G <sub>HG</sub>	High Gain Mode	32	34.5	37	dB
	G <sub>HG_TEMP</sub>	T <sub>EPAD</sub> = -40 to 105°C	31		38	
Gain Attenuated	G <sub>LG</sub>	Low Gain Mode		29		dB
Noise Figure	NF	Measured at antenna port ideally matched to LNA		1.2	1.4	dB
		T <sub>EPAD</sub> = 105°C			1.9	
		Low Gain Mode		1.2		

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] Specification reflects use of an external termination resistor at SW1\_OUT, SW2\_OUT with a RL > 22dB.

[c] Performance can be further improved with tuning at the SW1\_OUT and SW2\_OUT ports.

## Electrical Characteristics: 3300MHz [2]

Table 6. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance and TX Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3300MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Output Third-Order Intercept Point	OIP3 <sub>1</sub>	Pout = 0dBm/tone 5MHz tone separation		23		dBm
	OIP3 <sub>2</sub>	Pout = 0dBm/tone 5MHz tone separation $T_{EPAD} = -40$ to $105^{\circ}C$	20			
	OIP3 <sub>3</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode		22		
	OIP3 <sub>4</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	18			
Output 1dB Compression	OP1dB <sub>1</sub>	High Gain Mode <sup>[b]</sup>		15		dBm
	OP1dB <sub>2</sub>	High Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	G-24			
	OP1dB <sub>3</sub>	Low Gain Mode		14		
	OP1dB <sub>4</sub>	Low Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	G-18			
Channel Isolation	ISO <sub>CH</sub>	$RFISO_1 = \left( \frac{RX1\_OUT}{RX2\_OUT} \right)_{dB}$ with $-60 \leq SW1\_IN \leq -30dBm$  $RFISO_2 = \left( \frac{RX2\_OUT}{RX1\_OUT} \right)_{dB}$ with $-60 \leq SW2\_IN \leq -30dBm$	55	65		dB
RF Switch Isolation	ISO <sub>SW</sub>	Tx Mode Measured at SW_IN to RX_OUT of the same channel	59	69		dB

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] In the OP1dB calculation formula, "G" denotes the gain of each part instance at the frequency of interest and appropriate High / Low gain state.

## Electrical Characteristics: 3400MHz–3600MHz [1]

Table 7. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3500MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Input Return Loss	RL <sub>IN</sub>	Measured at SW1_IN, SW2_IN High Gain Mode, $f_{RF} = 3400MHz$ to 3600MHz	13 <sup>[a]</sup>			dB
		Measured at SW1_IN, SW2_IN Low Gain Mode, $f_{RF} = 3400MHz$ to 3600MHz	12			
		Measured at SW1_IN, SW2_IN TX mode <sup>[b]</sup> <sup>[c]</sup>	12			
Output Return Loss	RL <sub>OUT</sub>	Measured at RX1_OUT, RX2_OUT, High/Low Gain Modes, $f_{RF} = 3400MHz$ to 3600MHz	6			dB
Reverse Isolation, RX1_OUT to SW1_IN, or RX2_OUT to SW2_IN	ISO <sub>REV</sub>	$f_{RF} = 3400MHz$ to 3600MHz	54	64		dB
Gain	G <sub>HG</sub>	High Gain Mode	<b>32</b>	35	<b>37</b>	dB
	G <sub>HG_TEMP</sub>	$T_{EPAD} = -40$ to $105^{\circ}C$	31		38	
Gain Attenuated	G <sub>LG</sub>	Low Gain Mode	25.5	29	31.5	dB
Gain Ripple	G <sub>RIPPLE</sub>	$f_{RF} = 3400MHz$ to 3600MHz (Difference between maximum and minimum gain in each 100MHz subrange within the specified frequency range)		±0.2		dB
Noise Figure	NF	Measured at antenna port ideally matched to LNA		1.35	1.55	dB
		$T_{EPAD} = 105^{\circ}C$			2.1	
		Low Gain Mode		1.35		

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] Specification reflects use of an external termination resistor at SW1\_OUT, SW2\_OUT with a RL > 22dB.

[c] Performance can be further improved with tuning at the SW1\_OUT and SW2\_OUT ports.

## Electrical Characteristics: 3400MHz–3600MHz [2]

Table 8. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance and TX Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3500MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Output Third-Order Intercept Point	OIP <sub>31</sub>	Pout = 0dBm/tone 5MHz tone separation		23		dBm
	OIP <sub>32</sub>	Pout = 0dBm/tone 5MHz tone separation $T_{EPAD} = -40$ to $105^{\circ}C$	20			
	OIP <sub>33</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode		23		
	OIP <sub>34</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	18			
Output 1dB Compression	OP1dB <sub>1</sub>	High Gain Mode <sup>[b]</sup>		15		dBm
	OP1dB <sub>2</sub>	High Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	G-24			
	OP1dB <sub>3</sub>	Low Gain Mode		14		
	OP1dB <sub>4</sub>	Low Gain Mode $T_{EPAD} = -40$ to $105^{\circ}C$	G-18			
Channel Isolation	ISO <sub>CH</sub>	$RFISO_1 = \left( \frac{RX1\_OUT}{RX2\_OUT} \right)_{dB}$ with $-60 \leq SW1\_IN \leq -30dBm$  $RFISO_2 = \left( \frac{RX2\_OUT}{RX1\_OUT} \right)_{dB}$ with $-60 \leq SW2\_IN \leq -30dBm$	55	65		dB
RF Switch Isolation	ISO <sub>SW</sub>	Tx Mode Measured at SW_IN to RX_OUT of the same channel	59	69		dB

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] In the OP1dB calculation formula, "G" denotes the gain of each part instance at the frequency of interest and appropriate High / Low gain state.

## Electrical Characteristics: 3600MHz–3800MHz [1]

Table 9. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3700MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Input Return Loss	RL <sub>IN</sub>	Measured at SW1_IN, SW2_IN High Gain Mode, $f_{RF} = 3600MHz$ to 3800MHz	13 <sup>[a]</sup>			dB
		Measured at SW1_IN, SW2_IN Low Gain Mode, $f_{RF} = 3600MHz$ to 3800MHz	16			
		Measured at SW1_IN, SW2_IN TX mode <sup>[b] [c]</sup>	12			
Output Return Loss	RL <sub>OUT</sub>	Measured at RX1_OUT, RX2_OUT, High/Low Gain Modes, $f_{RF} = 3600MHz$ to 3800MHz	7			dB
Reverse Isolation, S <sub>12</sub>	ISO <sub>REV</sub>	$f_{RF} = 3600MHz$ to 3800MHz	53	63		dB
Gain	G <sub>HG</sub>	High Gain Mode	32	34	37	dB
	G <sub>HG_TEMP</sub>	$T_{EPAD} = -40$ to $105^{\circ}C$	30		38	
Gain Attenuated	G <sub>LG</sub>	Low Gain Mode	25	29	31.5	dB
Gain Ripple	G <sub>RIPPLE</sub>	$f_{RF} = 3600MHz$ to 3800MHz (Difference between maximum and minimum gain in each 100MHz subrange within the specified frequency range)		±0.4		dB
Noise Figure	NF	Measured at antenna port ideally matched to LNA		1.4	1.6	dB
		$T_{EPAD} = 105^{\circ}C$			2.25	
		Low Gain Mode		1.4		

[a] Items in Minimum/Maximum columns in ***bold italics*** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] Specification reflects use of an external termination resistor at SW1\_OUT, SW2\_OUT with a RL > 22dB.

[c] Performance can be further improved with tuning at the SW1\_OUT and SW2\_OUT ports.

## Electrical Characteristics: 3600MHz–3800MHz [2]

Table 10. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance and TX Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3700MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Output Third-Order Intercept Point	OIP <sub>31</sub>	Pout = 0dBm/tone 5MHz tone separation		23		dBm
	OIP <sub>32</sub>	Pout = 0dBm/tone 5MHz tone separation $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	20			
	OIP <sub>33</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode		23		
	OIP <sub>34</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	18			
Output 1dB Compression	OP1dB <sub>1</sub>	High Gain Mode <sup>[b]</sup>		15		dBm
	OP1dB <sub>2</sub>	High Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	G-24			
	OP1dB <sub>3</sub>	Low Gain Mode		14		
	OP1dB <sub>4</sub>	Low Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	G-18			
Channel Isolation	ISO <sub>CH</sub>	$RFISO_1 = \left( \frac{RX1\_OUT}{RX2\_OUT} \right)_{dB}$ with $-60 \leq SW1\_IN \leq -30dBm$  $RFISO_2 = \left( \frac{RX2\_OUT}{RX1\_OUT} \right)_{dB}$ with $-60 \leq SW2\_IN \leq -30dBm$	55	65		dB
RF Switch Isolation	ISO <sub>SW</sub>	Tx Mode Measured at SW_IN to RX_OUT of the same channel	55	65		dB

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] In the OP1dB calculation formula, "G" denotes the gain of each part instance at the frequency of interest and appropriate High / Low gain state.

## Electrical Characteristics: 3800MHz–4000MHz [1]

Table 11. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3900MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Input Return Loss	RL <sub>IN</sub>	Measured at SW1_IN, SW2_IN High Gain Mode, $f_{RF} = 3800MHz$ to 4000MHz	9 [a]			dB
		Measured at SW1_IN, SW2_IN Low Gain Mode, $f_{RF} = 3800MHz$ to 4000MHz	9			
		Measured at SW1_IN, SW2_IN TX mode [b] [c]	11			
Output Return Loss	RL <sub>OUT</sub>	Measured at RX1_OUT, RX2_OUT, High/Low Gain Modes, $f_{RF} = 3800MHz$ to 4000MHz	6			dB
Reverse Isolation, S <sub>12</sub>	ISO <sub>REV</sub>	$f_{RF} = 3800MHz$ to 4000MHz	52	62		dB
Gain	G <sub>HG</sub>	High Gain Mode	30	33	35	dB
	G <sub>HG_TEMP</sub>	$T_{EPAD} = -40$ to $105^{\circ}C$	28		38	
Gain Attenuated	G <sub>LG</sub>	Low Gain Mode		27.5		dB
Gain Ripple	G <sub>RIPPLE</sub>	$f_{RF} = 3800MHz$ to 4000MHz (Difference between maximum and minimum gain in each 100MHz subrange within the specified frequency range)		±0.5		dB
Noise Figure	NF	Measured at antenna port ideally matched to LNA		1.5	2	dB
		$T_{EPAD} = 105^{\circ}C$			2.5	
		Low Gain Mode		1.5		

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] Specification reflects use of an external termination resistor at SW1\_OUT, SW2\_OUT with a RL > 22dB.

[c] Performance can be further improved with tuning at the SW1\_OUT and SW2\_OUT ports.



## Electrical Characteristics: 3800MHz–4000MHz [2]

Table 12. Electrical Characteristics: RX Path in Rx Mode Cascaded Performance and TX Performance

See the F0453C Application Circuit. Specifications apply when operated as an Rx RF amplifier with  $V_{DD} = +3.3V$ ,  $f_{RF} = 3900MHz$ ,  $T_{EPAD} = +25^{\circ}C$ ,  $STBY = LOW$ , RX output power = -10dBm,  $Z_S = Z_L = 50\Omega$ , and EVKit trace and connector losses are de-embedded unless otherwise noted.

Parameter	Symbol	Condition	Minimum	Typical	Maximum	Units
Output Third-Order Intercept Point	OIP3 <sub>1</sub>	Pout = 0dBm/tone 5MHz tone separation		22		dBm
	OIP3 <sub>2</sub>	Pout = 0dBm/tone 5MHz tone separation $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	18			
	OIP3 <sub>3</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode		22		
	OIP3 <sub>4</sub>	Pout = 0dBm/tone 5MHz tone separation Low Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	17			
Output 1dB Compression	OP1dB <sub>1</sub>	High Gain Mode <sup>[b]</sup>		13		dBm
	OP1dB <sub>2</sub>	High Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	G-24			
	OP1dB <sub>3</sub>	Low Gain Mode		12		
	OP1dB <sub>4</sub>	Low Gain Mode $T_{EPAD} = -40^{\circ}C$ to $105^{\circ}C$	G-18			
Channel Isolation	ISO <sub>CH</sub>	$RFISO_1 = \left( \frac{RX1\_OUT}{RX2\_OUT} \right)_{dB}$ with $-60 \leq SW1\_IN \leq -30dBm$  $RFISO_2 = \left( \frac{RX2\_OUT}{RX1\_OUT} \right)_{dB}$ with $-60 \leq SW2\_IN \leq -30dBm$	50	60		dB
RF Switch Isolation	ISO <sub>SW</sub>	Tx Mode Measured at SW_IN to RX_OUT of the same channel	53	63		dB

[a] Items in Minimum/Maximum columns in **bold italics** are confirmed by test. Items in Minimum/Maximum columns NOT in bold italics are confirmed by design characterization.

[b] In the OP1dB calculation formula, "G" denotes the gain of each part instance at the frequency of interest and appropriate High / Low gain state.

## Thermal Characteristics

Table 13. Thermal Characteristics

Parameter	Symbol	Value	Units
Junction-to-Ambient Thermal Resistance	$\theta_{JA}$	31.2	°C/W
Junction-to-Case Thermal Resistance (Case is defined as the exposed paddle)	$\theta_{JC\_BOT}$	3.4	°C/W
Moisture Sensitivity Rating (Per J-STD-020)		MSL3	

## Typical Operating Conditions

Unless otherwise noted:

- $V_{DD} = +3.3V$
- $T_{EPAD} = 25^{\circ}C$
- $Z_L = Z_S = 50\Omega$  single-ended with matching networks
- STBY = Low or open
- SW\_CTRL = Low or open
- Gain Setting = High Gain Mode
- $P_{IN} \leq -30dBm$
- All temperatures are referenced to the exposed paddle
- Evaluation Kit traces and connector losses are de-embedded

## Programming

Table 14. Gain Step Truth Table

ATT1_CTRL, ATT2_CTRL	Attenuation Setting
Low or NC	0dB
High	6dB

Table 15. Standby and RF Switch Truth Table

In TX Mode, the amplifiers are OFF, but the bias will remain ON for fast turn-on recovery time.

STBY	SW_CTRL	MODE	Amplifier State
Low or NC	Low or NC	RX	ON
Low or NC	High	TX	OFF
High	High or Low or NC	STANDBY	OFF

# Typical Performance Characteristics

Figure 2. Rx Mode Gain (High Gain)

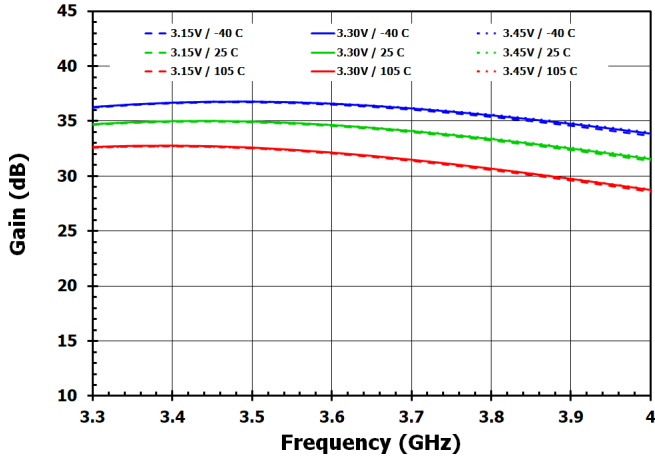


Figure 3. Rx Mode Gain (Low Gain)

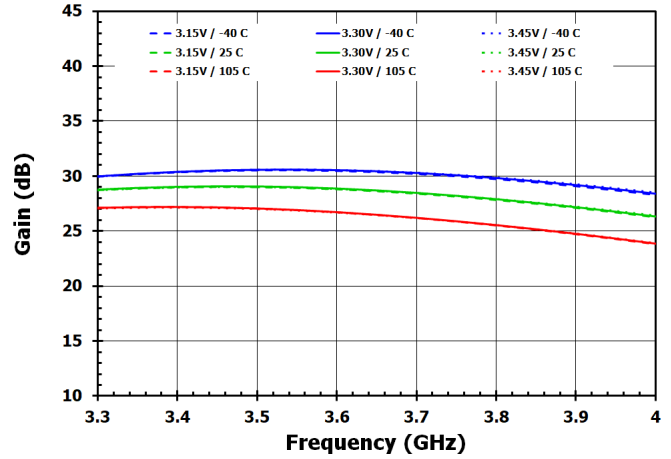


Figure 4. Rx Mode Reverse Isolation (High Gain)

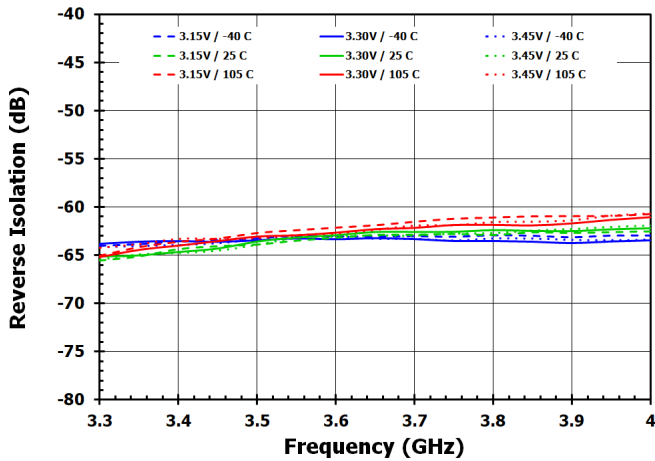


Figure 5. Rx Mode Reverse Isolation (Low Gain)

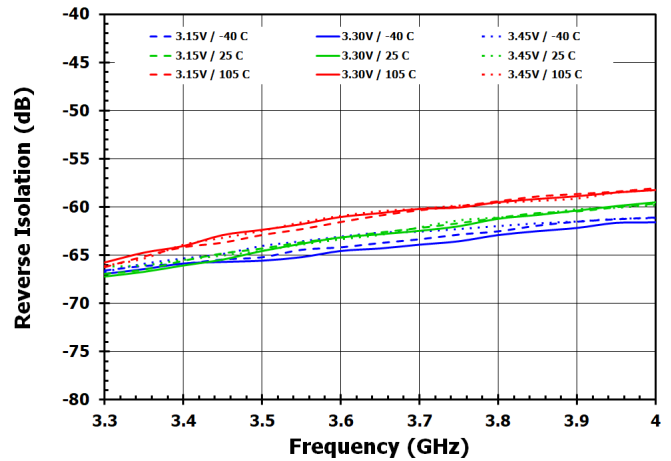


Figure 6. Rx Mode Input Return Loss (High Gain)

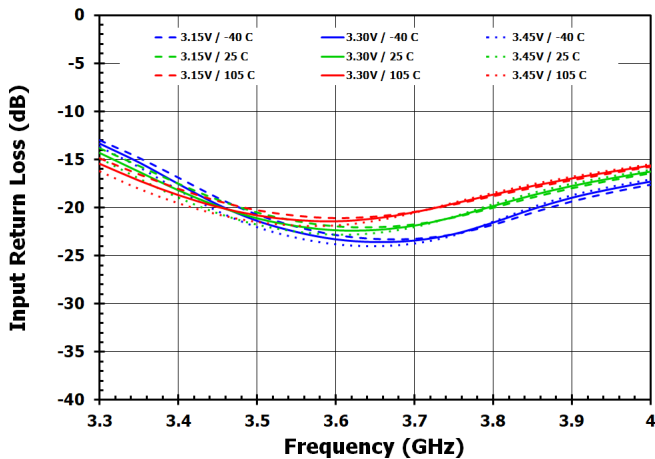


Figure 7. Rx Mode Input Return Loss (Low Gain)

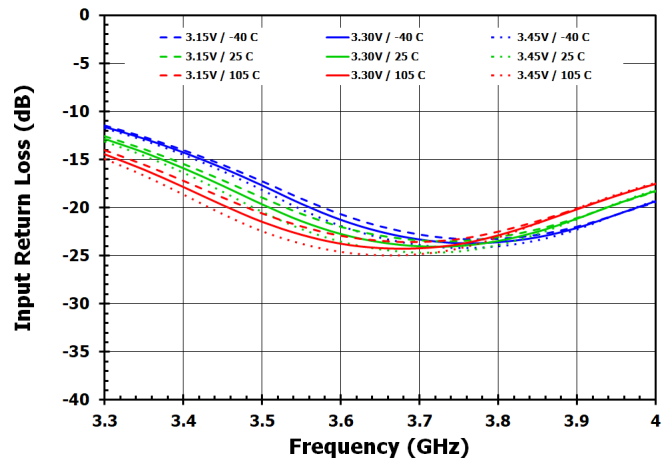


Figure 8. Rx Mode Output Return Loss (High Gain)

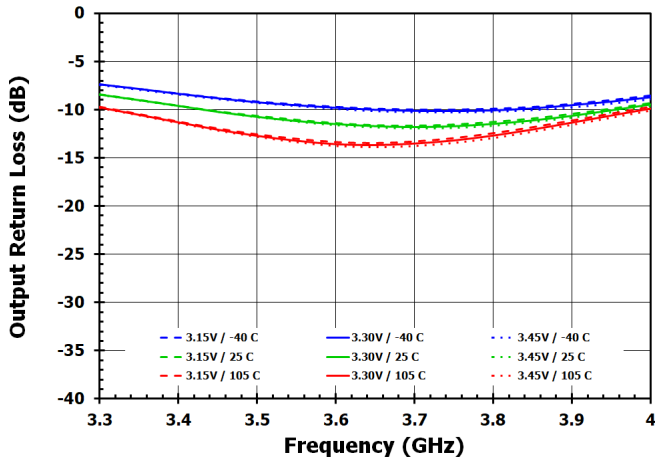


Figure 9. Rx Mode Output Return Loss (Low Gain)

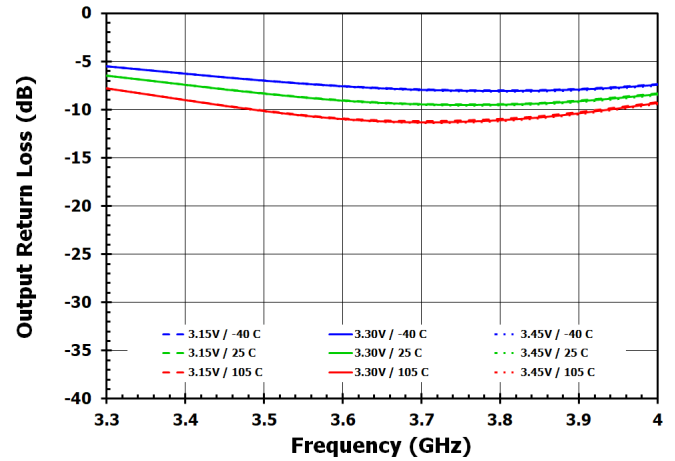


Figure 10. Rx Mode OP1dB (High Gain)

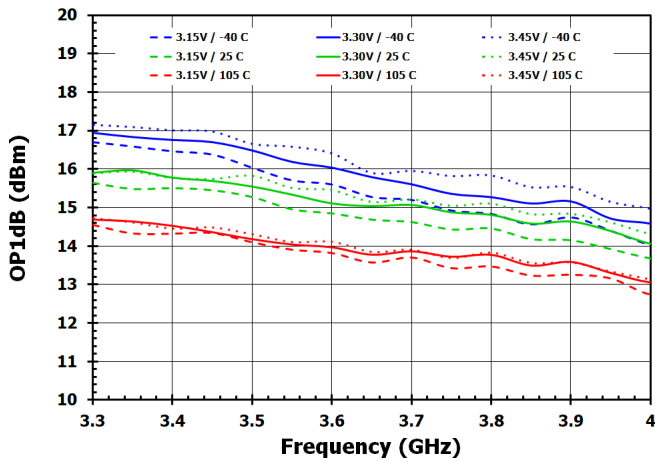


Figure 11. Rx Mode OP1dB (Low Gain)

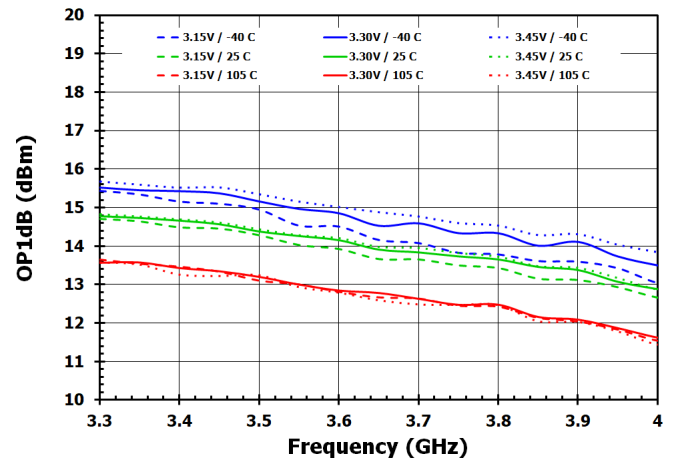


Figure 12. Rx Mode OIP3 (High Gain)

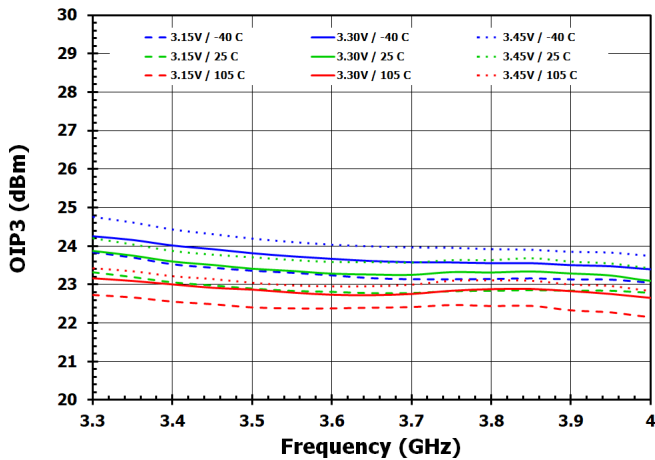


Figure 13. Rx Mode OIP3 (Low Gain)

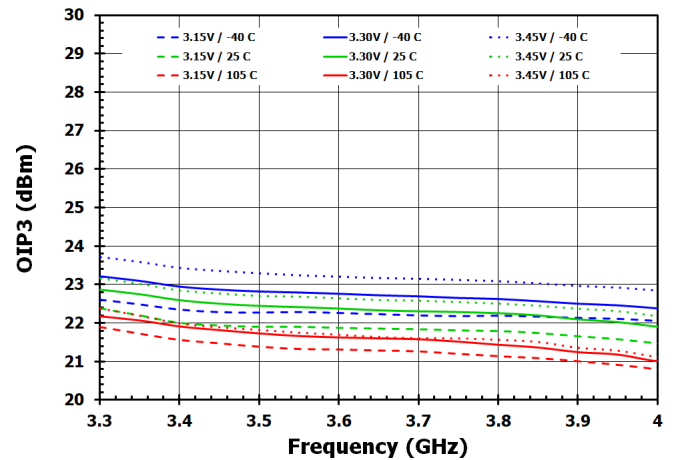


Figure 14. Rx Mode Noise Figure (High Gain)

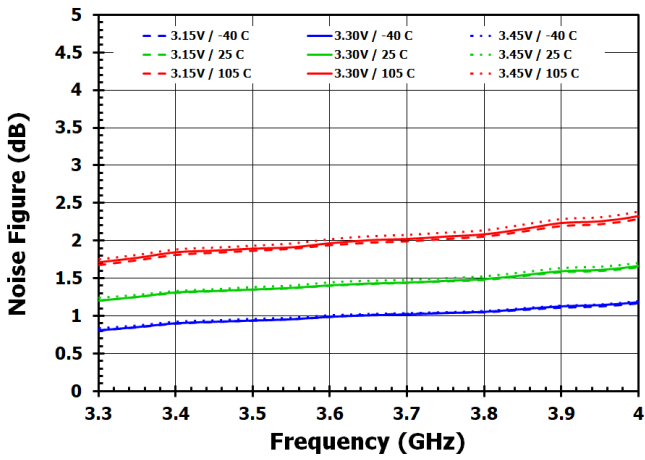


Figure 15. Rx Mode Noise Figure (Low Gain)

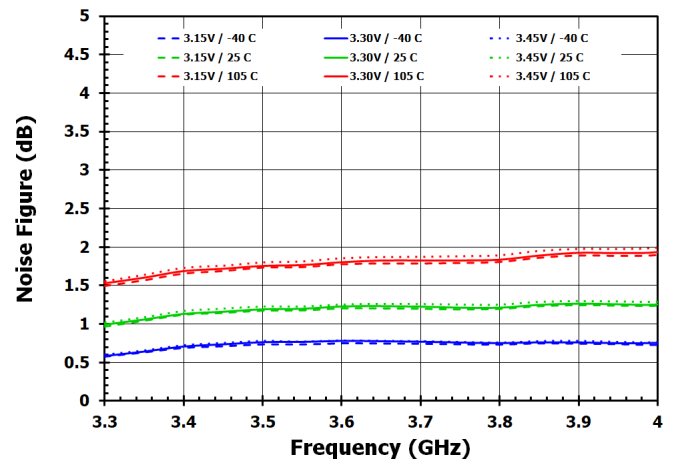


Figure 16. Tx Mode RF Switch Isolation

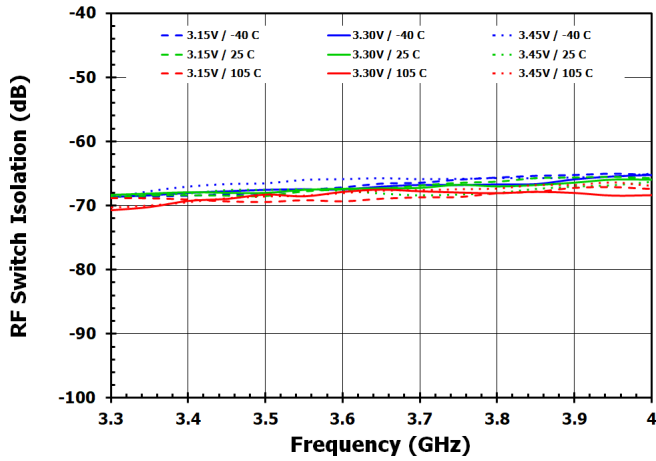


Figure 17. Rx Mode Channel Isolation

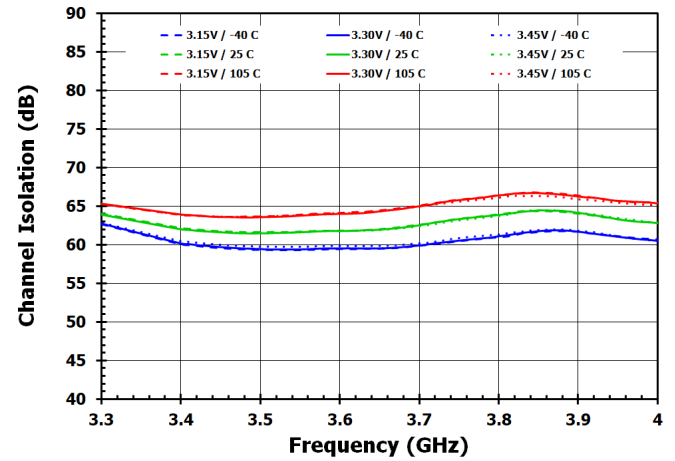


Figure 18. Stability K-factor

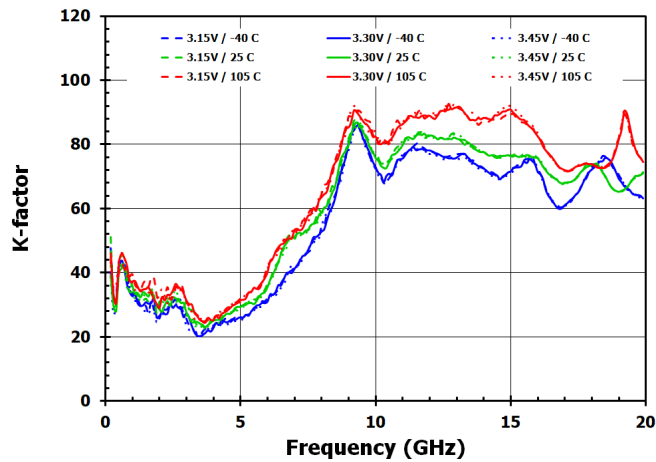


Figure 19. Gain Settling Time

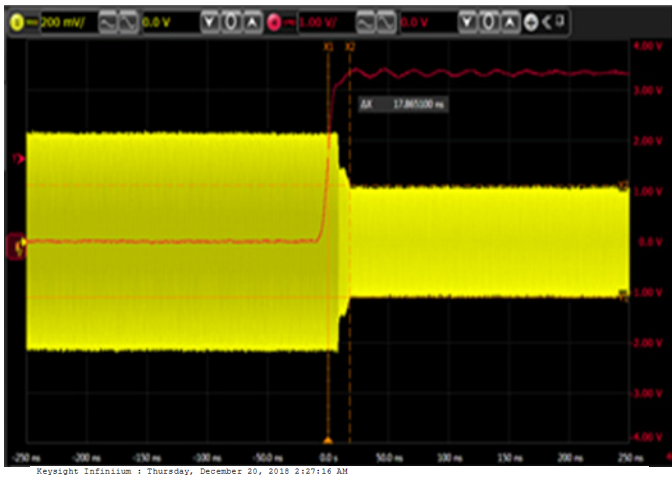


Figure 20. Gain Step Phase Settling Time

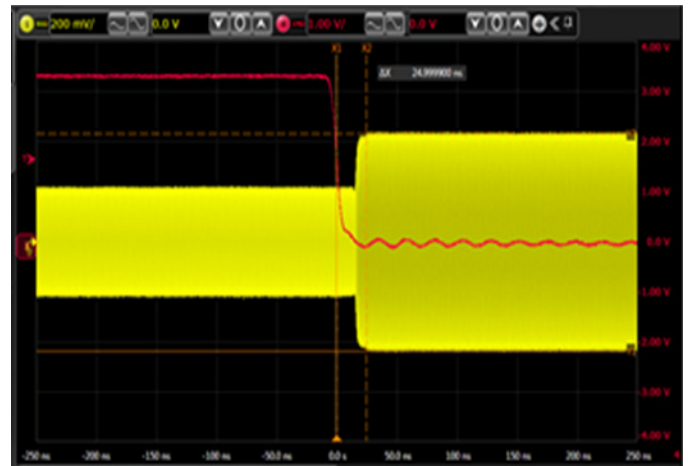


Figure 21. Power OFF Switching Time

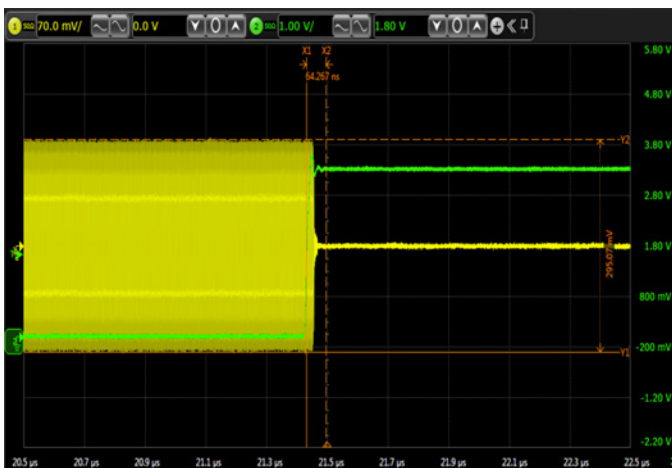


Figure 22. Power ON Switching Time

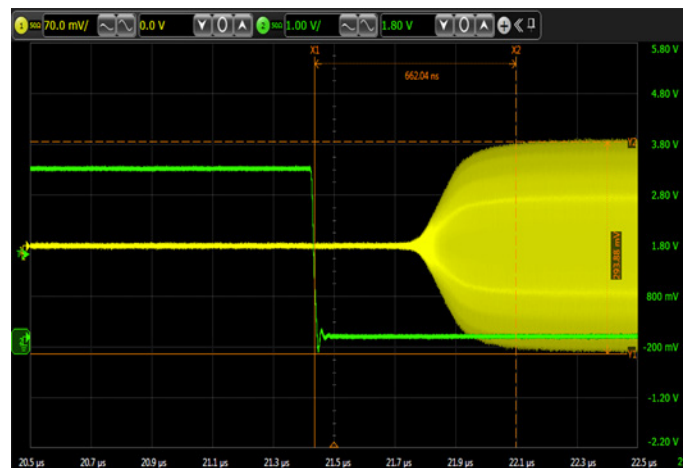


Figure 23. Power OFF to Standby Mode

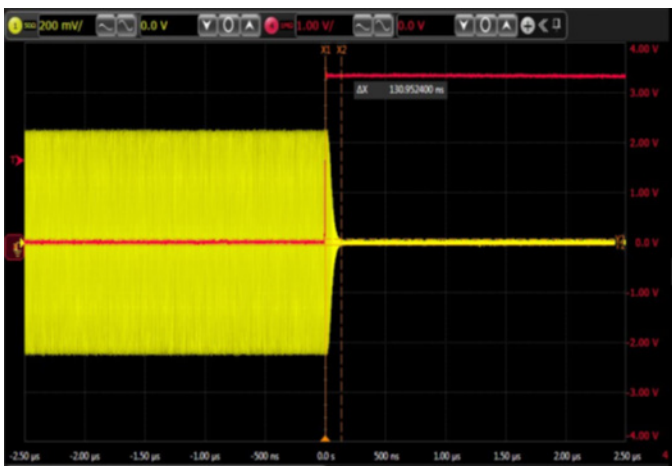
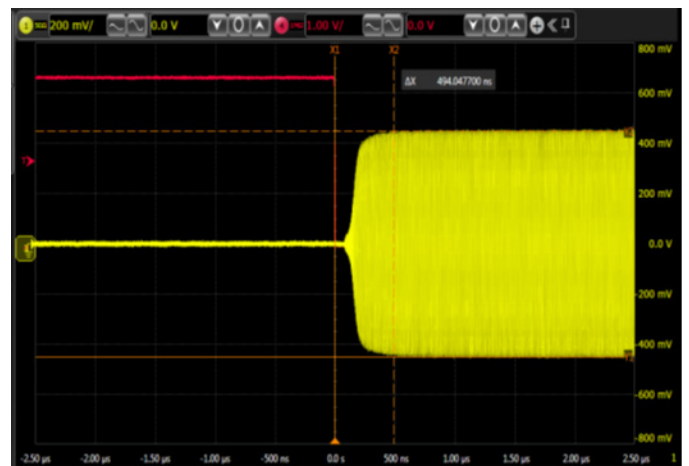


Figure 24. Power ON from Standby Mode



## Evaluation Kit Picture

Figure 25. Evaluation Kit: Top View

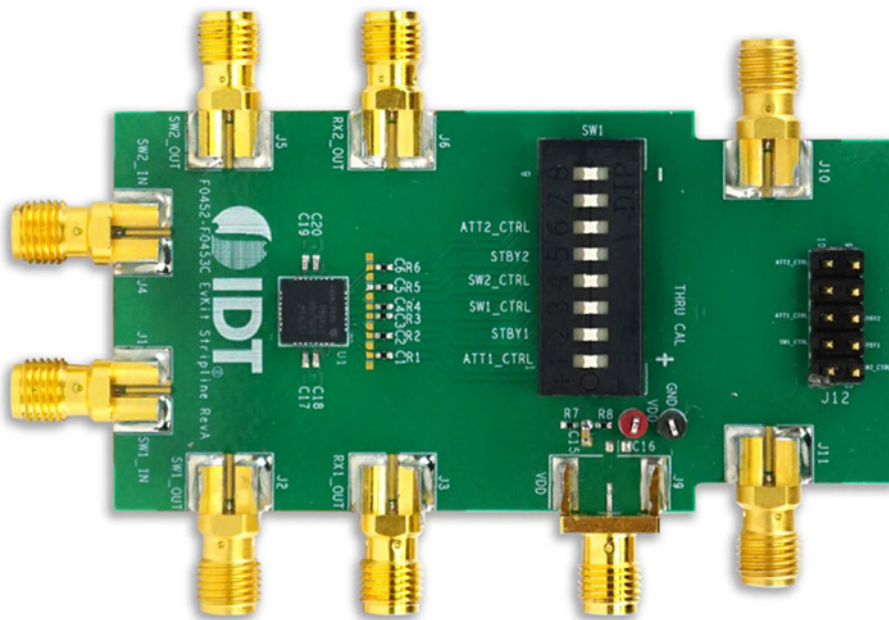
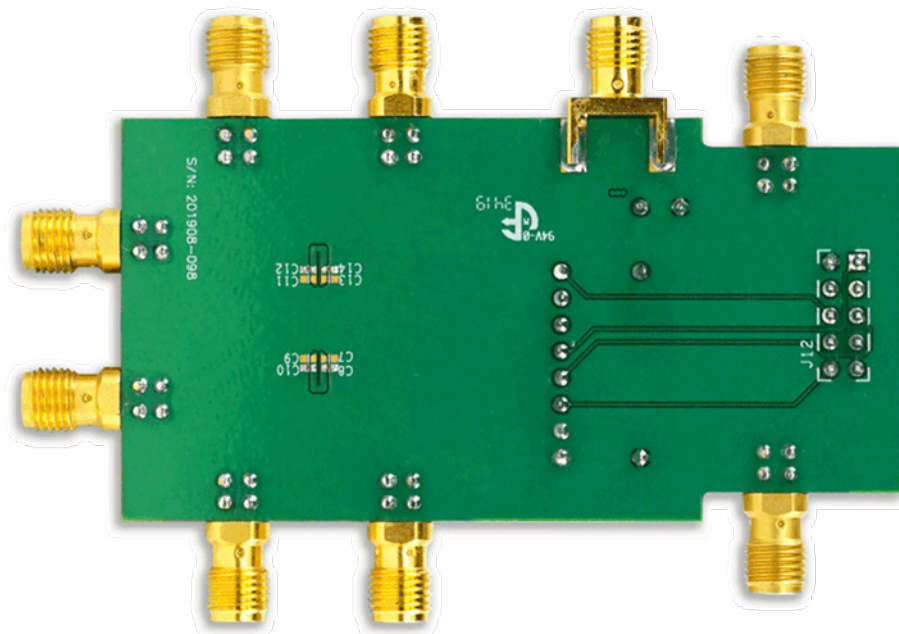


Figure 26. Evaluation Kit: Bottom View



# Evaluation Kit Circuit

Figure 27. Electrical Schematic

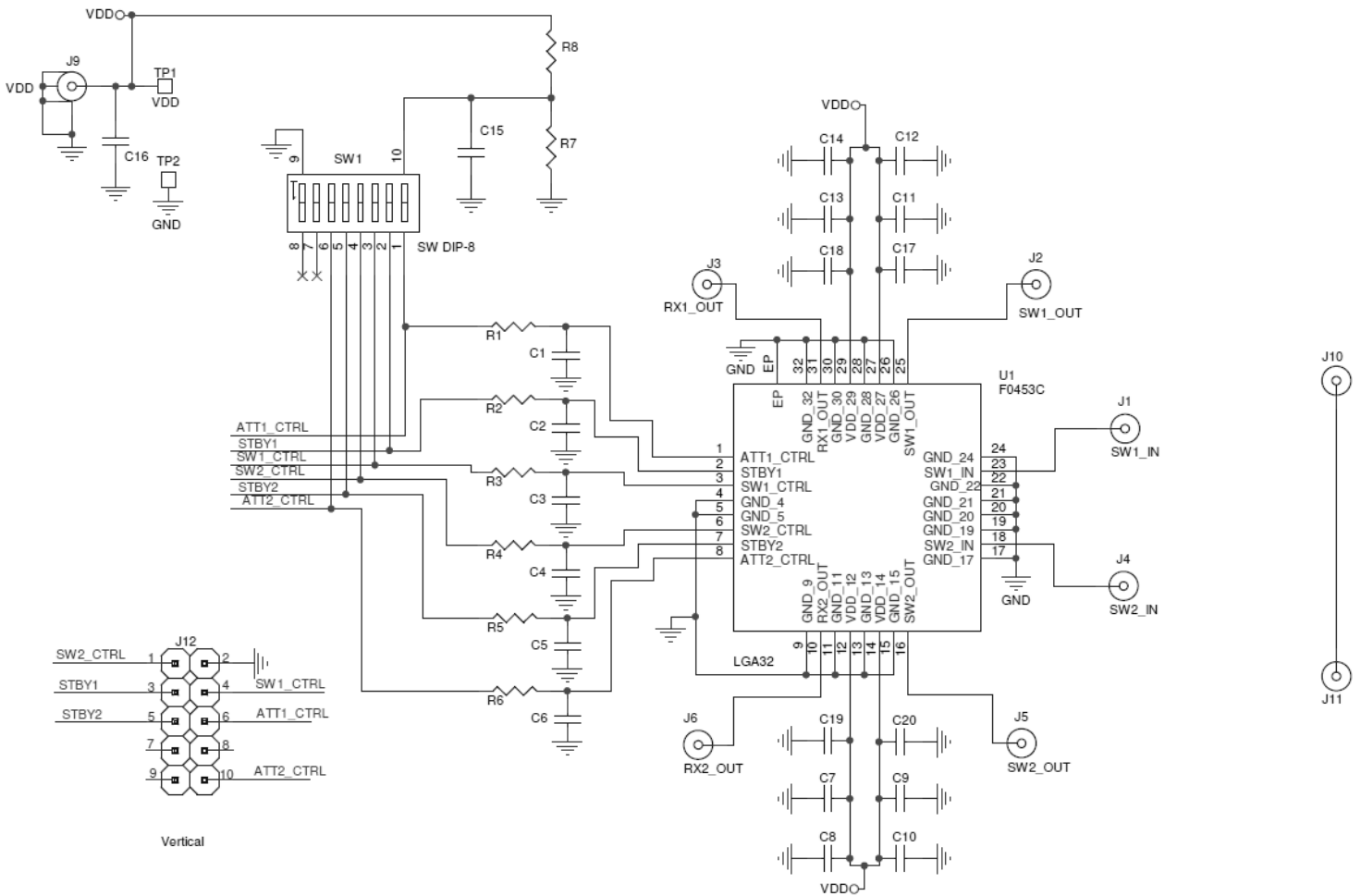




Table 16. Bill of Materials (BOM)

Part Reference	Qty	Description	Manufacturer Part #	Manufacturer
C2,C3,C4,C5	DNI	100pF ±5%, 50V, C0G Ceramic Capacitor (0402)	GRM1555C1H101J	MURATA
C7,C9,C11,C13	DNI	10nF ±5%, 50V, X7R Ceramic Capacitor (0402)	GRM155R71H103J	MURATA
C8,C10,C12,C14	4	1µF ±10% 10V Ceramic Capacitor X5R 0402	GRM155R61A105KE15D	MURATA
C17,C18,C19,C20	4	8pF ±0.1pF 50V Ceramic Capacitor C0G,NP0 (0402)	GJM1555C1H8R0B	MURATA
C15	1	10nF ±5%, 50V, X7R Ceramic Capacitor (0603)	GRM188R71H103K	MURATA
R1,R2,R3,R4,R5,R6	6	0Ω Resistors (0402)	ERJ-2GE0R00X	PANASONIC
R7	1	1kΩ ±1%, 1/10W, Resistor (0402)	ERJ-2RKF1001X	PANASONIC
R8	1	1.3kΩ ±1%, 1/10W, Resistor (0402)	ERJ-2RKF1301X	PANASONIC
J1,J2,J3,J4,J5,J6, J10,J11	8	SMA Edge Mount	142-0761-881	Cinch Connectivity
J12	1	CONN HEADER VERT 2X5 POS GOLD	10-89-7100	3M
J9	1	Edge Launch SMA(0.375 inch pitch ground, tab) (50Ohm)	142-0701-851	Emerson Johnson
SW1	1	8-pin DIP Switch (3 POS)	KAT1108E	IDE-Switch
U1	1	Dual Path RF +LNA+DVGA 5x5 QFN	F0452C/F0453C LEG32K	Renesas
PCB	1	Printed Circuit Board	F0452C/F0453C Stripline Rev. B	
TEST POINT	DNI	BLACK/GND TP1	5001	Keystone Electronics
TEST POINT	DNI	RED/VCC TP2	5000	Keystone Electronics
C1,C6,C16	3	DNI		

# Application Information

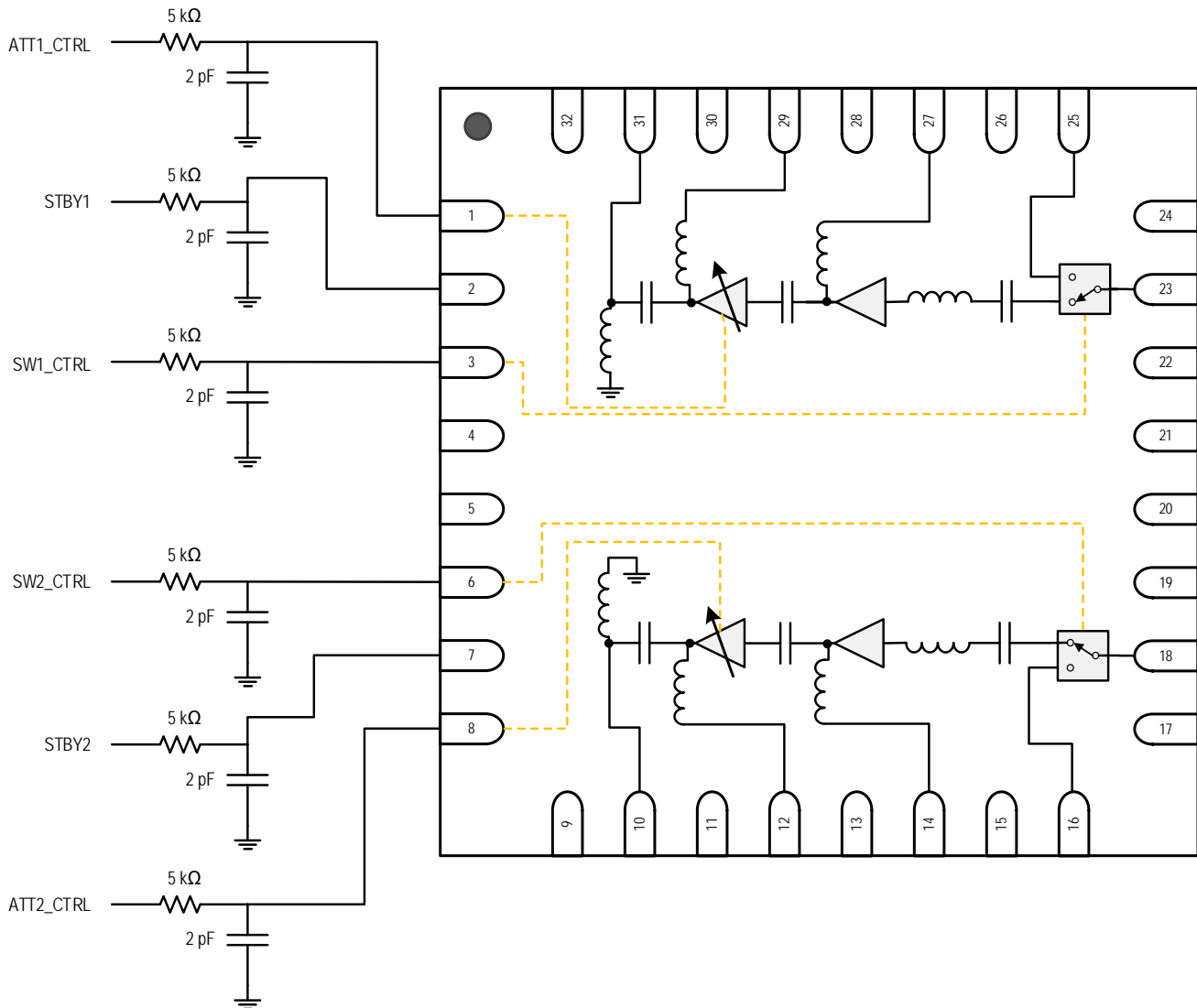
## Power Supplies

A common  $V_{DD}$  power supply should be used for all pins requiring DC power. All supply pins should be bypassed with external capacitors to minimize noise and fast transients. Supply noise can degrade the noise figure, and fast transients can trigger ESD clamps and cause them to fail. Supply voltage change or transients should have a slew rate smaller than  $1V / 20\mu s$ . In addition, all control pins should remain at  $0V (\pm 0.3V)$  while the supply voltage ramps up or while it returns to zero.

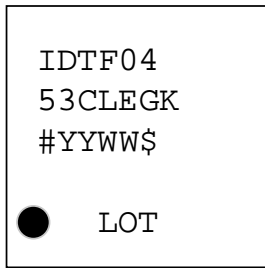
## Control Pin Interface

If control signal integrity is a concern and clean signals cannot be guaranteed due to overshoot, undershoot, ringing, etc., the following circuit at the input of each control pin is recommended. This applies to control pins 1, 2, 3, 6, 7, and 8 displayed in Figure 28.

Figure 28. Control Pin Interface Schematic



## Marking Diagram



- Lines 1 and 2 indicate the part number
- Line 3 indicates the following:
  - “#” denotes stepping
  - “YY” is the last two digits of the year; “WW” is the work week number when the part was assembled.
  - “\$” denotes the mark code.
- Line 4 is the lot number

## Package Outline Drawings

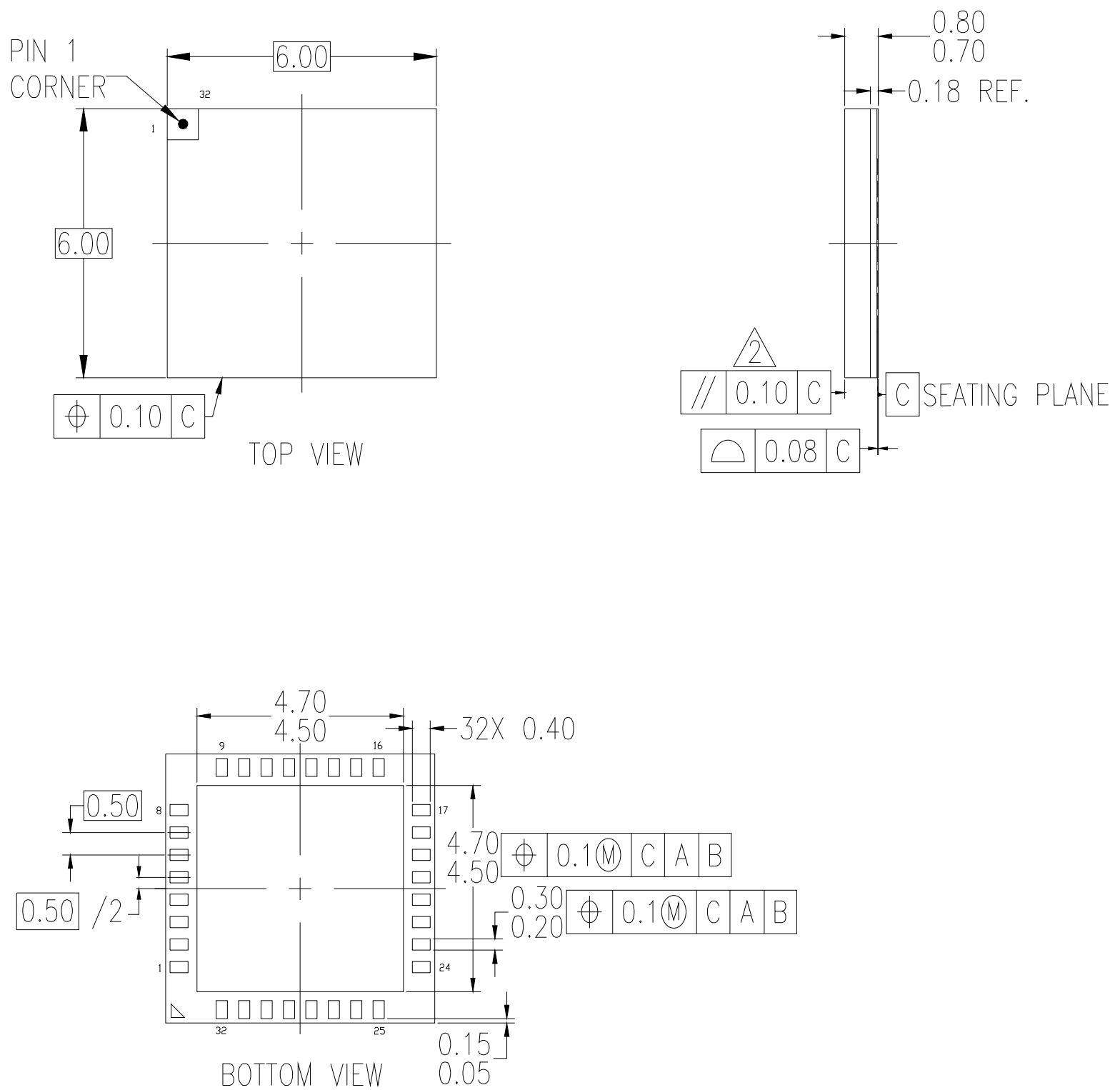
The package outline drawings are located at the end of this document and are accessible from the Renesas website (see package links in Ordering Information). The package information is the most current data available and is subject to change without revision of this document.

## Ordering Information

Part Number	Package Description	MSL Rating	Carrier Type	Temp. Range
F0453CLFGK	6 × 6 × 0.75 mm <a href="#">32-FCLGA</a>	MSL3	Tray	-40° to +105°C
F0453CLFGK8	6 × 6 × 0.75 mm <a href="#">32-FCLGA</a>	MSL3	Reel	-40° to +105°C
F0453CEVB	Evaluation Board			

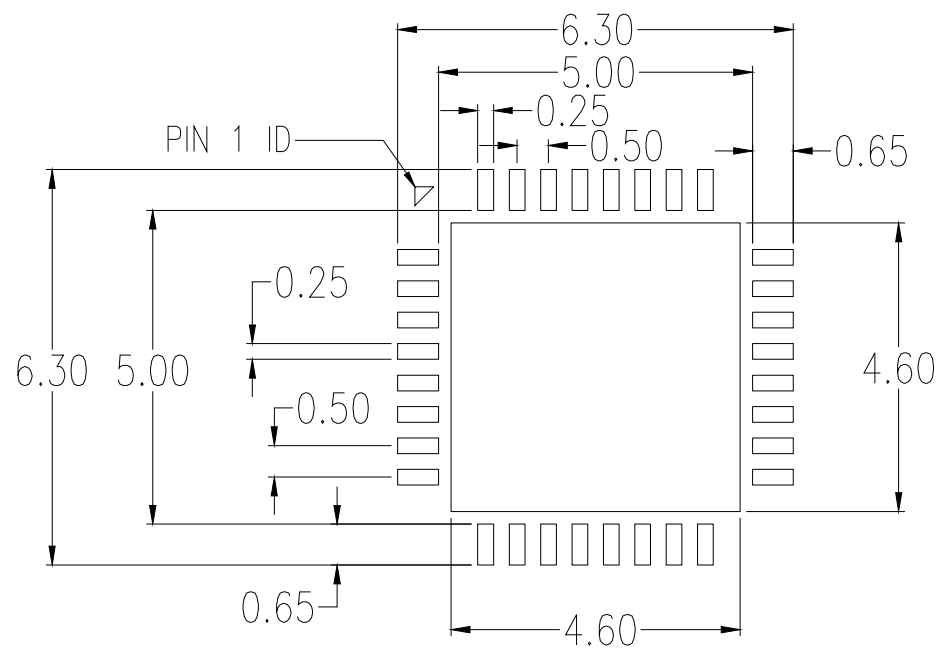
## Revision History

Revision Date	Description of Change
July 13, 2021	<ul style="list-style-type: none"> <li>• Updated V<sub>IL</sub> specification in Table 4.</li> <li>• Completed other minor changes.</li> </ul>
May 1, 2020	Added Application Information section.
February 26, 2020	Initial release.



NOTES:

1. ALL DIMENSIONS IN MM.
2. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.



RECOMMENDED LAND PATTERN DIMENSION

NOTES:

1. ALL DIMENSIONS ARE IN MM. ANGLES IN DEGREES.
2. TOP DOWN VIEW. AS VIEWED ON PCB.
3. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUIREMENT FOR SURFACE MOUNT DESIGN AND LAND PATTERN.

Package Revision History		
Date Created	Rev No.	Description
Apr 27, 2021	Rev 01	Update A1 to 0.18
July 18, 2019	Rev 00	Initial Release

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